Se	earch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
09/738,200	LEE, BRIAN CRAIG
Examiner	Art Unit

Saeid Ebrahimi-dehKordy

2626

	SEARCHED		
Class	Subclass	Date	Examiner
347	2,37,106	5/26/2005	SE
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TAI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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	DATE	EXMR
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